

<b>Notice of References Cited</b>	Application/Control No. 10/643,672	Applicant(s)/Patent Under Reexamination RAY ET AL.	
	Examiner Sheela C. Chawan	Art Unit 2624	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	K	US-			
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
*	U	Tolga et al., "Indexing large metric spaces for similarity search queries-- IDS. <i>September 1999</i>
*	V	Behzad Dariush et al., "Spatiotemporal analysis of face profiles" Detection, segmentation, and registration-IEEE 1998.
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
*	U	Tolga Bozkaya et al., "indexing large metric spaces for similarity search queries association for computing machinery transactions on database system", pages 1-34, 1999.
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<div style="border: 2px solid black; border-radius: 50%; width: 100px; height: 100px; display: flex; align-items: center; justify-content: center; margin: 0 auto;"> <div style="text-align: center;"> <p style="margin: 0;">O I INFORMATION DISCLOSURE CITATION</p> <p style="margin: 0;">(Use several sheets if necessary)</p> <p style="margin: 0;">JAN 20 2004</p> </div> </div>				ATTY DOCKET NO. ITL.0996US (P14028)		SERIAL NO. 10/643,672	
				APPLICANT(S): AJOY K. RAY, ET AL.			
				FILING DATE: August 19, 2003		GROUP ART UNIT: 2621	
				<b>U.S. PATENT DOCUMENTS</b>			
*EXAMINER INITIAL	TRADEMARK	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
scc	A.	6,345,109	02/05/2002	SOUMA ET AL.	382	118	
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EXAMINER /Sheela Chawan/				DATE CONSIDERED 12/22/2006			

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.